ShanghaiTech University School of Information Science and Technology

EE112 Lab Experiments

Experiment 3: Single Stage CE & CS Amplifier Pre-Lab Worksheet

Contents
1.1. Attentuation Network 1.2. Single Stage CE BJT Amplifier 1.3. Single Stage CS MOSFET Amplifier
1. Pre-Lab
To make the plots more readable and to save on printer toner, change the background color of your plots to white before printing your plot.
1.1. Attenuation Network
Attenuation Ratio V_{in}/V_{source} :
Equivalent Impedance R_{in} :
Draw Thevenin equivalent model:
1.2. Single Stage CE BJT Amplifier
Explain the function of R_e :
Small Signal Circuit:

Expression of middle band gain A_{ν} :

Expression of output impedance of the	e amplifier R_{out} :			
Expression of high cutoff frequency f	H;			
Table 1: Component Design				
Component Design	Hand Calculation	Multisim Simulation		
R_{b1}				
R_{b2}				
R_c				
R_e				
Table 2: Performance Verification				
Performance	Hand Calculation	Multisim Simulation		
Middle Band $Gain(A_{mid})$				
High Cutoff Frequency(f _H)				
Output Swing(SW)				
Total Power Consumption(P_{total})				
Plot Amplifier Gain (in dB20) v.s. Frequency:				
Plot Input and Output Waveforms sho	Plot Input and Output Waveforms showing the Output Swing:			
Flot input and Output waveforms snowing the Output Swing.				
.3. Single Stage CS MOSFET Amplifier				
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Explain the function of R_s :				
Small Signal Circuit:				
Sman Signai Circuit.				

Expression of middle band gain A_v :				
Expression of output impedance of the amplifier R_{out} :				
Expression of high cutoff frequency f_H :				
Table 3: Component Design				
Component Design	Hand Calculation	Multisim Simulation		
R_{g1}				
R_{g2}				
R_d				
R_s				
Table 4: Performance Verification				
Performance	Hand Calculation	Multisim Simulation		
Middle Band $Gain(A_{mid})$				
High Cutoff Frequency(f_H)				
Output Swing(SW)				
Total Power Consumption(P_{total})				
Plot Amplifier Gain (in dB20) v.s. Frequency:				
Plot Input and Output Waveforms showing the Output Swing:				

Reference

[1] UNIVERSITY OF CALIFORNIA AT BERKELEY, College of Engineering Department of Electrical Engineering and Computer Sciences, EE105 Lab Experiments